



10V Single Channel Load Switch

General Description

The EM5220 is a single channel load switch with programmable rise time and with an integrated output discharge control. The device contains a P-channel MOSFET that can operate over an input voltage range of 4.5V to 10V. The switch is controlled by an on and off low level logic input, which is capable of interfacing with GPIO signals. The programmable rise time of the device can reduce inrush current caused by large load capacitances during power up. The configurable DIS pin controls the on/off time of the device to allow design flexibility for controlling the power on/off sequence.

Ordering Information

| Part Number | Package | Note |
|-------------|----------------|------|
| EM5220VDT | TDFN2.0X2.0-08 | |

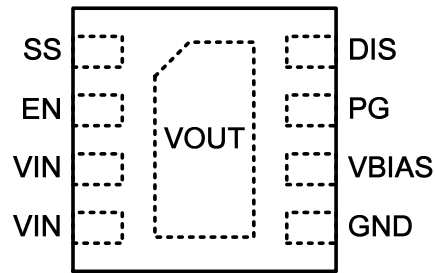
Features

- No External Gate Pull-Up Resistor Required
- 4.5V to 11V Input Voltage Range
- Low Typical $R_{DS(ON)}$ of 21m Ω
- Adjustable Start-Up and Discharge Rate
- TDFN2.0x2.0 with Thermal Pad
- Over Temperature Protection
- RoHS Compliant and 100% Lead (Pb)-Free

Applications

- Ultrabook
- Notebooks & Netbooks
- Set-top Boxes
- Tablet PC
- Telecom systems
- Consumer electronics

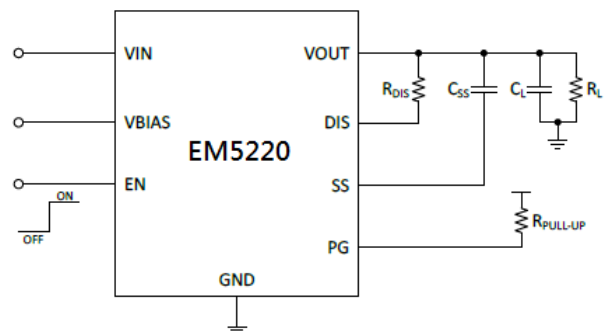
PIN Configuration



TOP VIEW

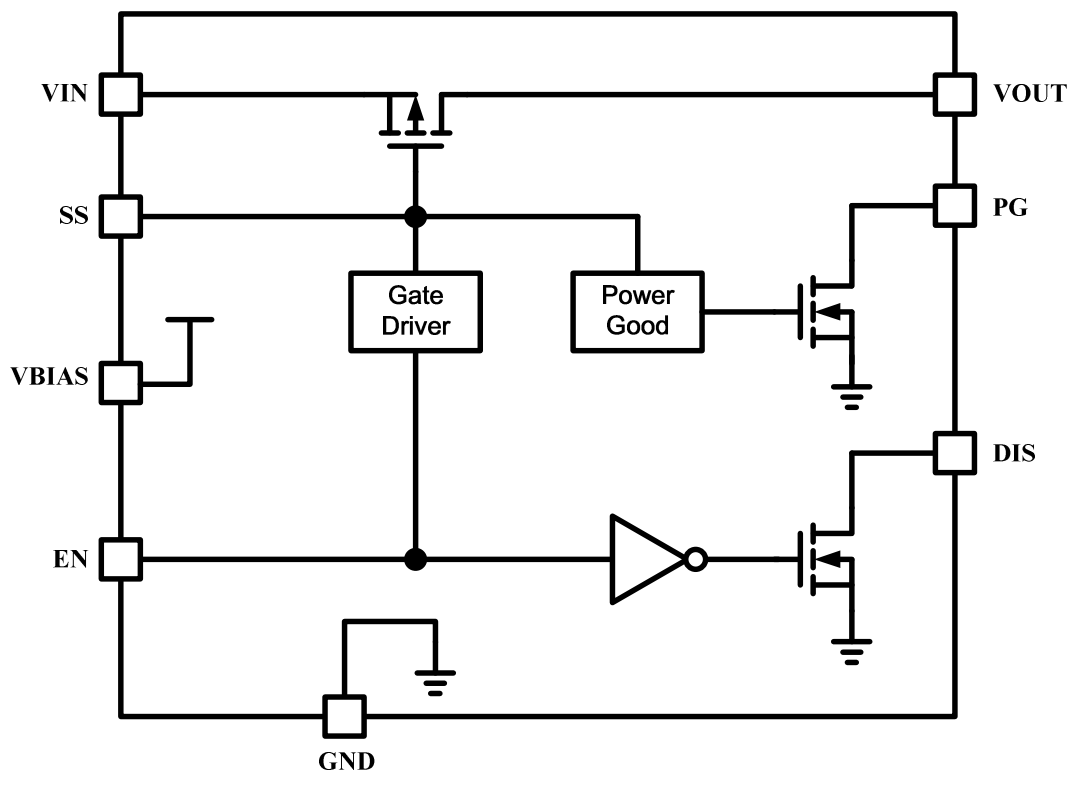
TDFN2.0X2.0-08

Typical Application Circuit



Pin Assignment

| Pin Name | Pin Number | Pin Function |
|----------|------------|--|
| SS | 1 | Soft Start. An external capacitor connected between SS and VOUT sets the soft-start time of the output voltage. The internal circuit controls the slew rate of the output voltage at turn on in order to limiting the inrush current. |
| EN | 2 | Enable Input Active high |
| VIN | 3, 4 | Input Voltage Connects to the Source of the P-channel MOSFET |
| GND | 5 | Ground |
| VBIAS | 6 | Bias supply voltage. Power supply to the device. Recommended voltage range for this pin is 2.5V to 5.5V. |
| PG | 7 | Power Good The PG pin is connected to the drain of an internal NFET. An external pull-up resistor is required at PG to indicate the status to downstream device. |
| DIS | 8 | Output Discharge An external resistor between DIS and VOUT sets the discharge rate of VOUT |
| VOUT | PAD | Output Voltage. VOUT is power output pin. PAD connects to the Drain of the P-channel MOSFET. |



Absolute Maximum Rating

| | |
|---|----------------|
| ● Input Voltage, V_{IN} ----- | -0.3V to +12V |
| ● Output Voltage, V_{OUT} ----- | -0.3V to +12V |
| ● Bias Voltage, V_{BIAS} ----- | -0.3V to +6.0V |
| ● Soft-start, V_{SS} ----- | -0.3V to +12V |
| ● DIS Pin, V_{DIS} ----- | -0.3V to +12V |
| ● Enable Voltage, V_{EN} ----- | -0.3V to +6.0V |
| ● Power Good, V_{PG} ----- | -0.3V to +12V |
| ● Power Dissipation, $P_D @ T_A = 25^\circ\text{C}$, TDFN2.0X2.0-08 | |
| (Note 2) ----- | 0.35W |
| (Note 3) ----- | 1.8W |
| ● Package Thermal Resistance, θ_{JA} , TDFN2.0X2.0-08 (Note 2) | |
| (Note 2) ----- | 300 °C /W |
| (Note 3) ----- | 60 °C /W |
| ● Junction Temperature----- | 150°C |
| ● Lead Temperature (Soldering, 10 sec.)----- | 260°C |
| ● Storage Temperature ----- | -65°C to 150°C |
| ● ESD susceptibility (Note4) | |
| HBM (Human Body Mode)----- | 2KV |
| MM (Machine Mode)----- | 200V |
| CDM(Charge Device Mode)----- | 1KV |

Recommended Operating Conditions (Note5)

| | |
|----------------------------------|----------------|
| ● Input Voltage, V_{IN} ----- | +4.5V to +11V |
| ● Bias Voltage, V_{BIAS} ----- | +2.5V to +5.5V |
| ● Enable Voltage, V_{EN} ----- | +0V to +5.5V |
| ● Junction Temperature ----- | -40°C to 125°C |
| ● Ambient Temperature ----- | -40°C to 85°C |

Electrical Characteristics

$V_{BIAS} = 2.5 \sim 5V$, $C_{IN}=1\mu F$, $C_L=100nF$, $T_A=25^\circ C$, unless otherwise specified

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Units |
|-----------------------------------|-----------------|---|-------------------|------|------|-------|
| VIN Quiescent Current | I_{VIN_Q} | $I_{OUT} = 0A$, $V_{BIAS}=5V$ | $V_{IN} = 10V$ | 1 | | uA |
| | | | $V_{IN} = 8.4V$ | 0.65 | | |
| | | | $V_{IN} = 5V$ | 0.14 | | |
| | I_{VIN_Q} | $I_{OUT} = 0A$, $V_{BIAS}=2.5V$ | $V_{IN} = 10V$ | 1 | | uA |
| | | | $V_{IN} = 8.4V$ | 0.65 | | |
| | | | $V_{IN} = 5V$ | 0.14 | | |
| VIN Shutdown Current | I_{VIN_SD} | $V_{IN} = 10V$, $V_{EN} = 0V$ | | 1.5 | | nA |
| VBIAS Quiescent Current | I_{VBIAS_Q} | $V_{IN} = 10V$, $V_{BIAS}=5V$, $I_{OUT} = 0A$ | | 0.3 | | nA |
| | | $V_{IN} = 10V$, $V_{BIAS}=2.5V$, $I_{OUT} = 0A$ | | 0.1 | | |
| VBIAS Shutdown Current | I_{VBIAS_SD} | $V_{IN} = 10V$, $V_{BIAS}=5V$, $V_{EN} = 0V$ | | 0.2 | | nA |
| | | $V_{IN} = 10V$, $V_{BIAS}=2.5V$, $V_{EN} = 0V$ | | 0.1 | | |
| Load Switch On-Resistance | $R_{DS(ON)}$ | $I_{OUT} = 1A$ | $V_{IN} = 10V$ | 21 | 31 | mΩ |
| | | | $V_{IN} = 8.4V$ | 21 | 31 | |
| | | | $V_{IN} = 5V$ | 23 | 33 | |
| EN Input Logic High Voltage | V_{IH_EN} | | 1 | | | V |
| EN Input Logic Low Voltage | V_{IL_EN} | | | | 0.5 | V |
| EN Input Leakage | I_{LEAK_EN} | $V_{EN} = V_{BIAS}$ | | | 100 | nA |
| Discharge FET On-Resistance | R_{DS_DIS} | $V_{EN} = 0V$, $I_{DIS} = 10mA$ | $V_{BIAS} = 5.0V$ | 8 | 20 | Ω |
| | | | $V_{BIAS} = 2.5V$ | 11 | 25 | |
| Power Good Output Low Level | V_{OL_PG} | $I_{OL_PG} = 100\mu A$, $V_{EN} = 0V$ | | | 0.2 | V |
| Power Good High-Impedance Current | I_{OZ_PG} | $V_{PG} = V_{BIAS}$, $V_{EN} = V_{BIAS}$ | | | 0.05 | uA |

Note 1. Stresses listed as the above “Absolute Maximum Ratings” may cause permanent damage to the device. These are for stress ratings. Functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may remain possibility to affect device reliability.

Note 2. For a device surface mounted on minimum recommended pad layout, in still air conditions; the device is measured when operating in a steady state condition.

Note 3. For a device surface mounted on 25mm by 25mm by 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady state condition.

Note 4. Devices are ESD sensitive. Handling precaution is recommended.

Note 5. The device is not guaranteed to function outside its operating conditions.

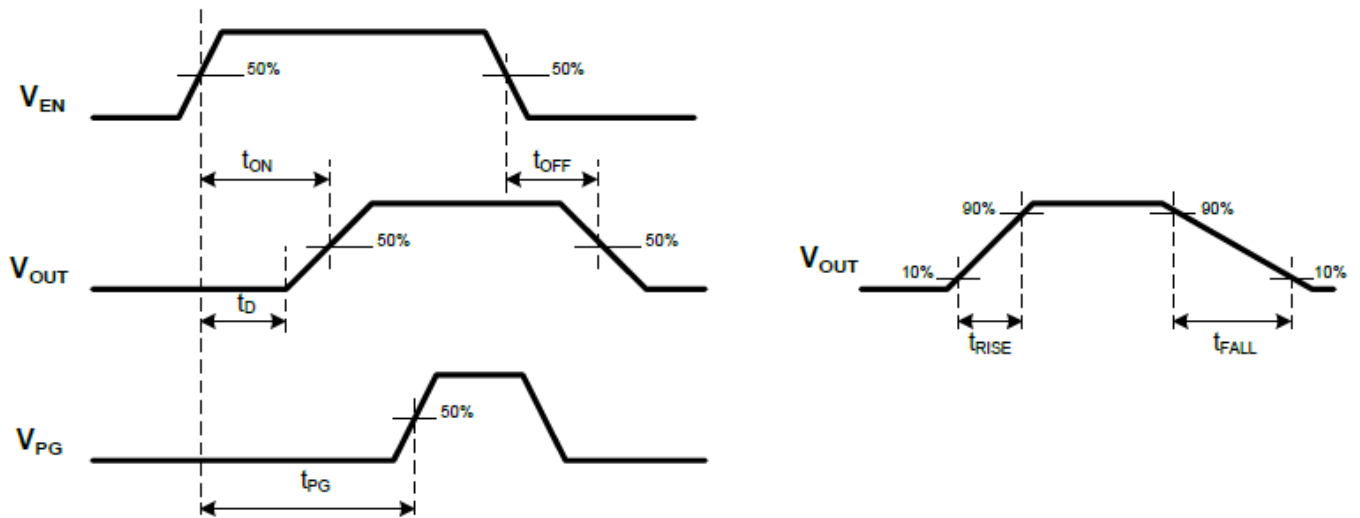
Note 6. EMC will review datasheet by quarter, and update new version.

Switching Characteristics

$V_{BIAS} = 2.5 \sim 5V$, $C_{IN}=1\mu F$, $C_L=100nF$, $T_A=25^\circ C$, unless otherwise specified

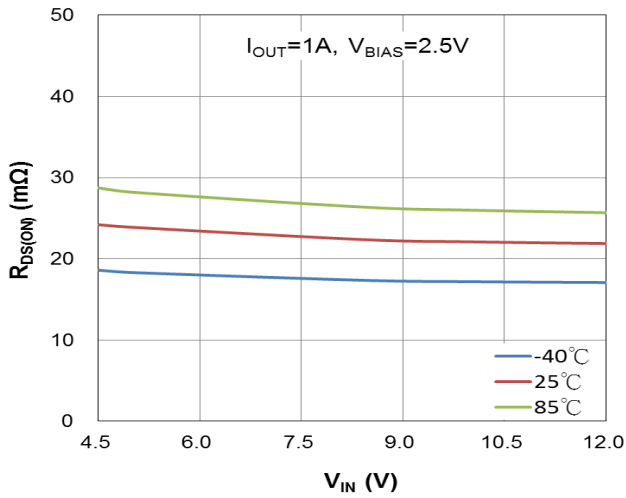
| Parameter | Symbol | Test Conditions | Min | Typ | Max | Units |
|----------------------------|------------|---|-----------------|-----|-----|-------|
| Output Rise Time | t_{RISE} | $R_L = 10\Omega$ $C_{SS} = 10nF$ | $V_{IN} = 10V$ | | 150 | us |
| | | | $V_{IN} = 8.4V$ | | | |
| | | | $V_{IN} = 5V$ | | | |
| Output Turn-ON Delay Time | t_{ON} | $R_L = 10\Omega$ $C_{SS} = 10nF$ | $V_{IN} = 10V$ | | 90 | us |
| | | | $V_{IN} = 8.4V$ | | | |
| | | | $V_{IN} = 5V$ | | | |
| Output Fall Time | t_{FALL} | $R_L = \text{Open}$ $R_{DIS} = 240\Omega$, $C_{SS} = 10nF$ | $V_{IN} = 10V$ | | 70 | us |
| | | | $V_{IN} = 8.4V$ | | | |
| | | | $V_{IN} = 5V$ | | | |
| Output Turn-OFF Delay Time | t_{OFF} | $R_L = \text{Open}$ $R_{DIS} = 240\Omega$, $C_{SS} = 10nF$ | $V_{IN} = 10V$ | | 30 | us |
| | | | $V_{IN} = 8.4V$ | | | |
| | | | $V_{IN} = 5V$ | | | |
| Output Start Delay Time | t_D | $R_L = 10\Omega$ $C_{SS} = 10nF$ | $V_{IN} = 10V$ | | 20 | us |
| | | | $V_{IN} = 8.4V$ | | | |
| | | | $V_{IN} = 5V$ | | | |
| Power Good Delay Time | t_{PG} | $R_L = 10\Omega$ $C_{SS} = 10nF$ | $V_{IN} = 10V$ | | 400 | us |
| | | | $V_{IN} = 8.4V$ | | | |
| | | | $V_{IN} = 5V$ | | | |

t_{ON}/t_{OFF} Waveforms

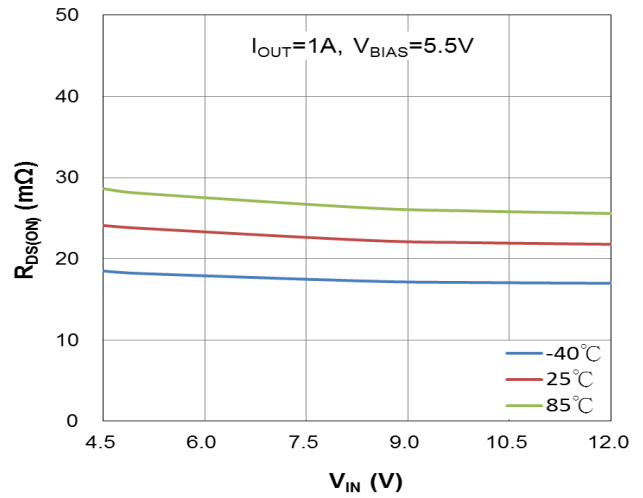


Typical Operating Characteristics

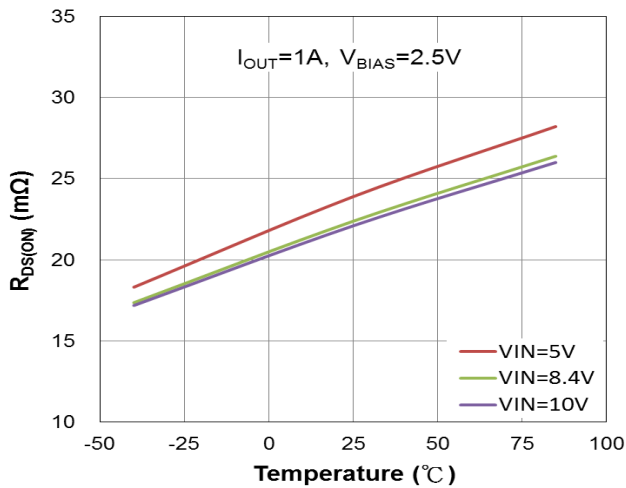
$R_{DS(ON)}$ vs. V_{IN} ($V_{BIAS}=2.5V$)



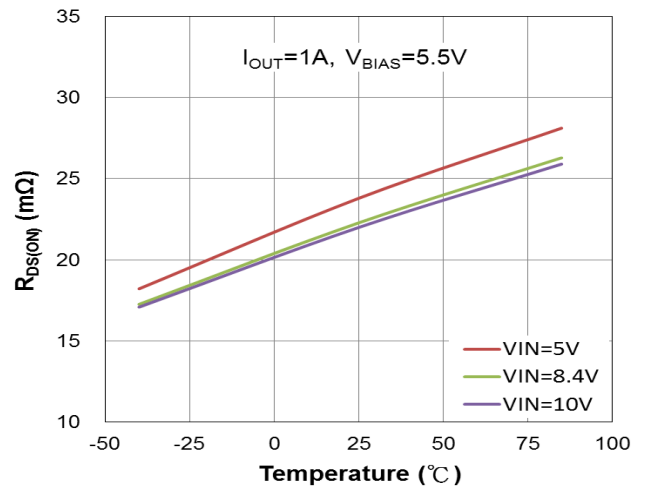
$R_{DS(ON)}$ vs. V_{IN} ($V_{BIAS}=5.5V$)



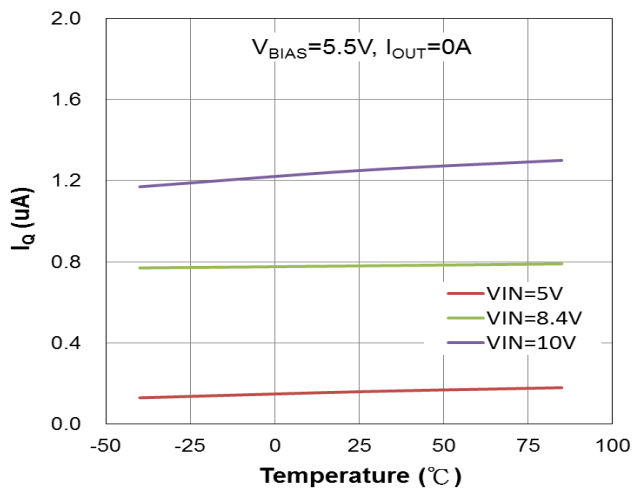
$R_{DS(ON)}$ vs. Temperature ($V_{BIAS}=2.5V$)



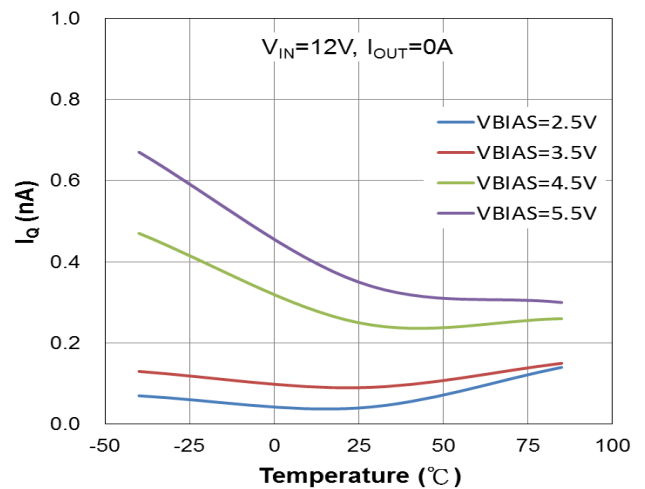
$R_{DS(ON)}$ vs. Temperature ($V_{BIAS}=5.5V$)



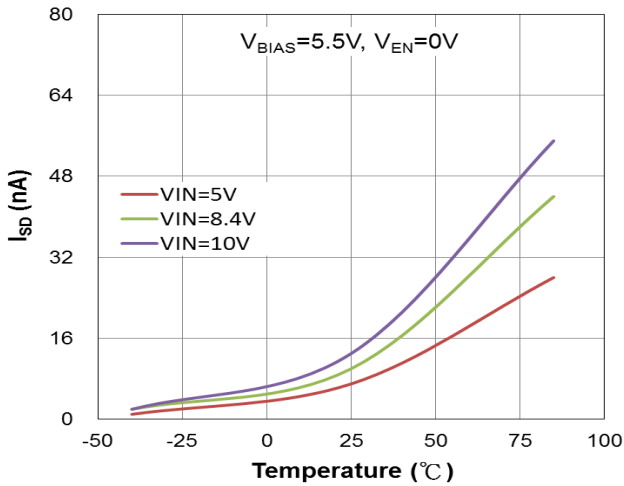
V_{IN} Quiescent Current vs Temperature



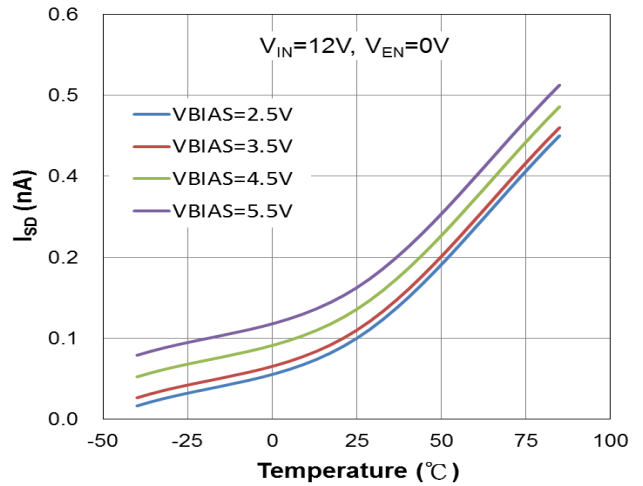
V_{BIAS} Quiescent Current vs Temperature



V_{IN} Shutdown Current vs Temperature

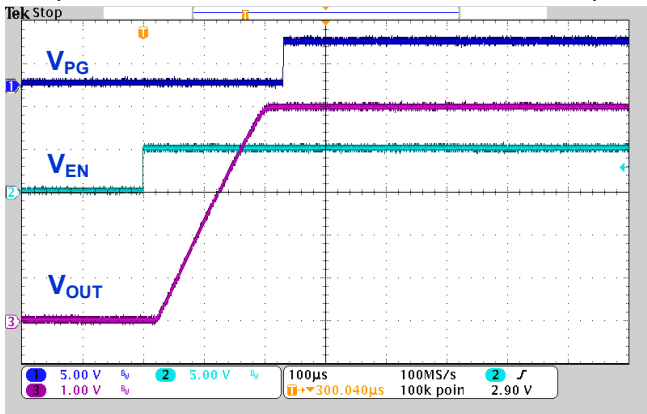


V_{BIAS} Shutdown Current vs Temperature



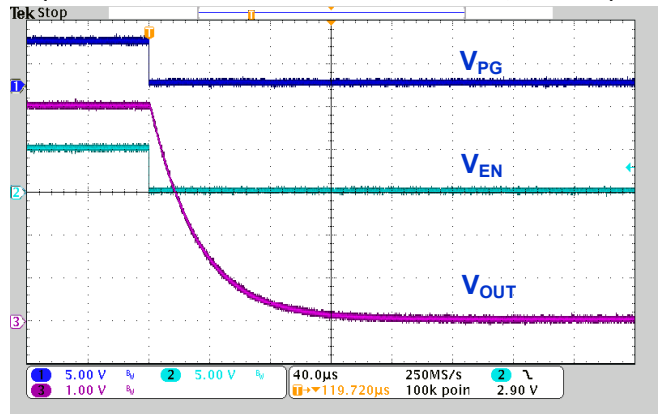
Turn On Test Waveform ($V_{IN}=5V$)

($T_A=25^\circ C, R_L=10\Omega, C_{SS}=10nF, C_L=0.1\mu F, C_{IN}=1\mu F$)



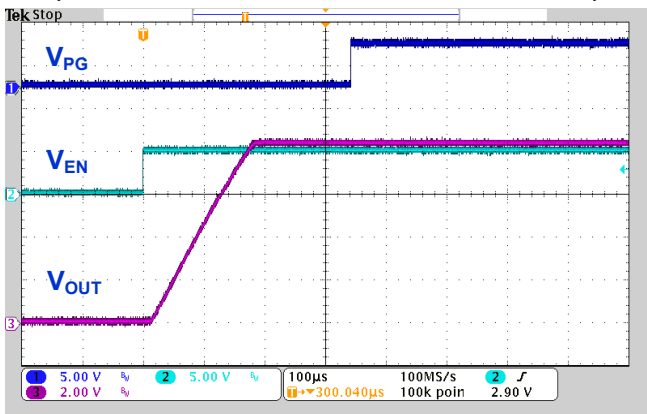
Turn Off Test Waveform ($V_{IN}=5V$)

($T_A=25^\circ C, R_{DIS}=243\Omega, C_{SS}=10nF, C_L=0.1\mu F, C_{IN}=1\mu F$)



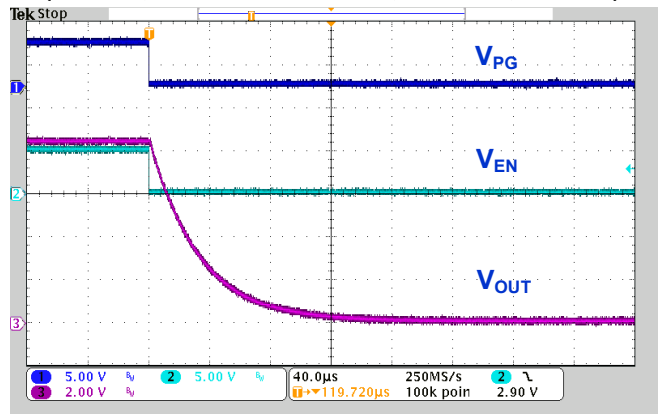
Turn On Test Waveform ($V_{IN}=8.4V$)

($T_A=25^\circ C, R_L=10\Omega, C_{SS}=10nF, C_L=0.1\mu F, C_{IN}=1\mu F$)



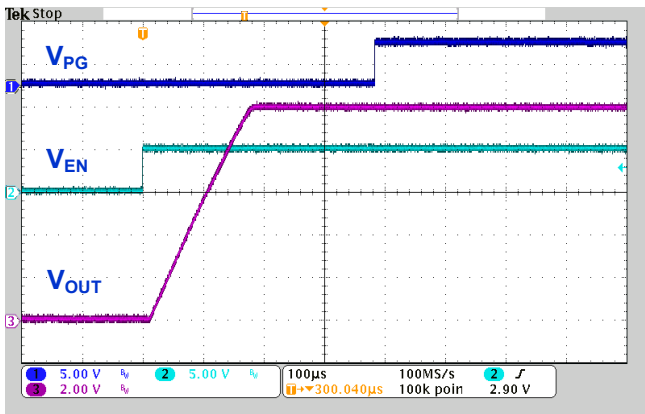
Turn Off Test Waveform ($V_{IN}=8.4V$)

($T_A=25^\circ C, R_{DIS}=243\Omega, C_{SS}=10nF, C_L=0.1\mu F, C_{IN}=1\mu F$)



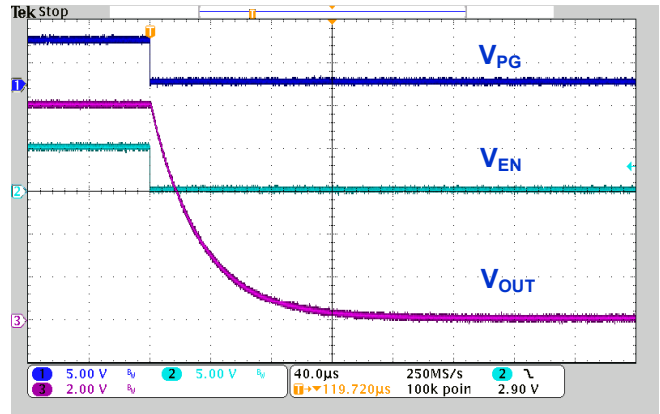
Turn On Test Waveform ($V_{IN}=10V$)

($T_A=25^\circ C$, $R_L=10\Omega$, $C_{SS}=10nF$, $C_L=0.1\mu F$, $C_{IN}=1\mu F$)

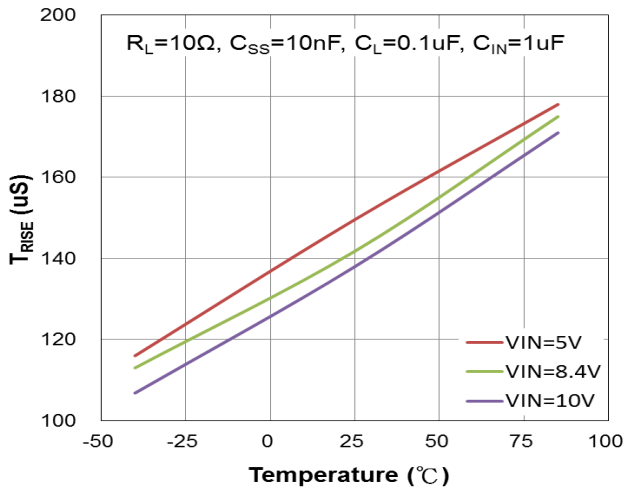


Turn Off Test Waveform ($V_{IN}=10V$)

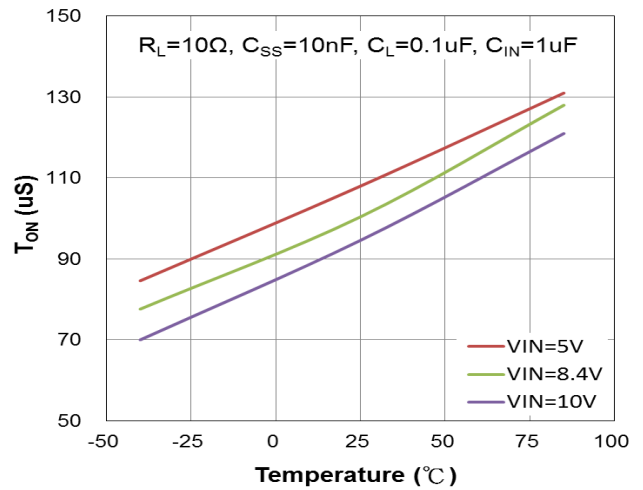
($T_A=25^\circ C$, $R_{DIS}=243\Omega$, $C_{SS}=10nF$, $C_L=0.1\mu F$, $C_{IN}=1\mu F$)



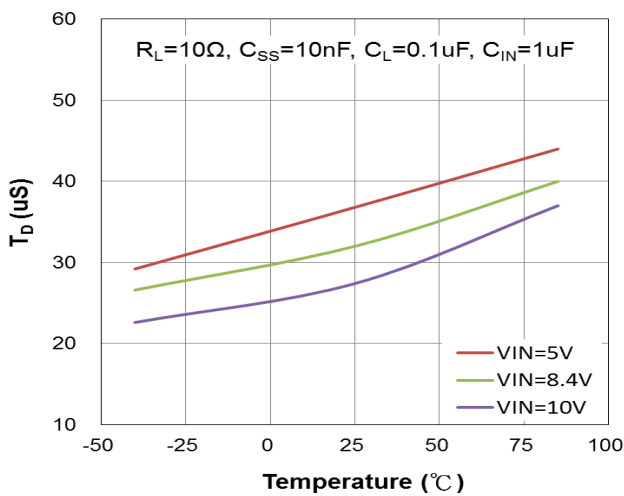
T_{RISE} vs Temperature



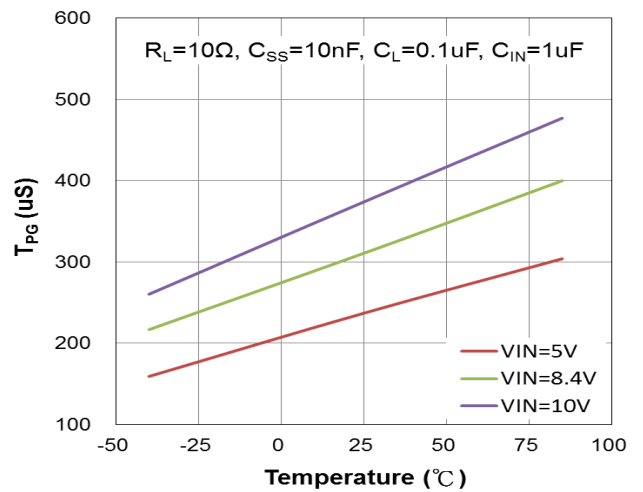
T_{ON} vs Temperature



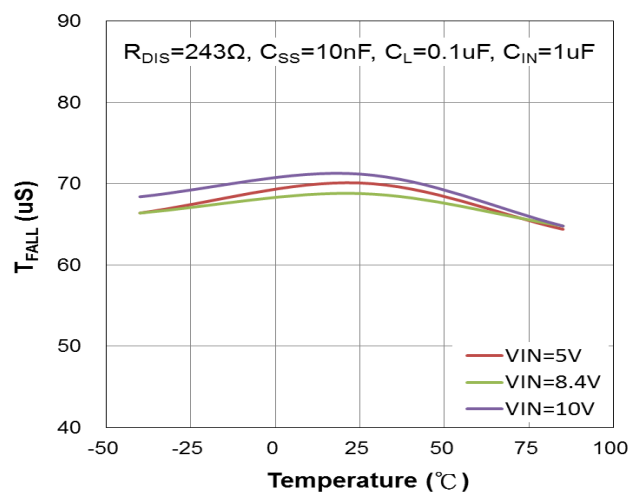
T_D vs Temperature



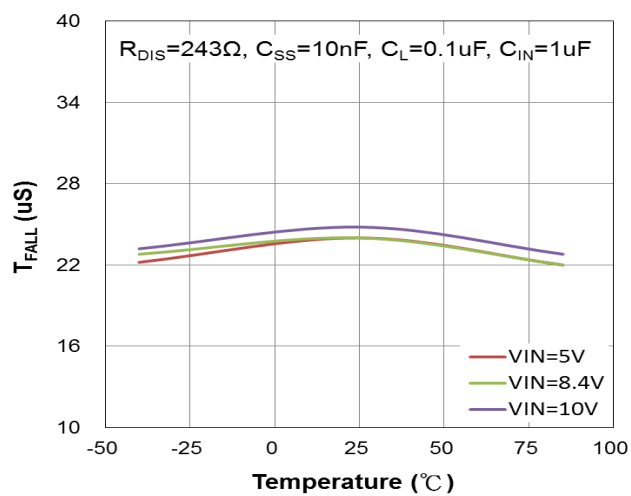
T_{PG} vs Temperature



T_{FALL} vs Temperature



T_{OFF} vs Temperature



Application Information

Adjustable Slew Rate/Soft-Start

SS pin allows the output ramp time of the switch to be controlled using an external capacitor (C_{SS}). This timing capacitor is connected between the SS and V_{OUT} pin. Rise times (μS) for different values of C_{SS} and V_{IN} are shown in the table below with $V_{BIAS} = 5.5\text{V}$.

| Rise Time (μS) | | | | |
|---|----------------------|----------------------|---------------------|---------------------|
| Measured at +25 °C using 0805 X7R 10% 50V capacitor, $C_L=100\text{nF}$, $R_{DIS}=243\text{ohm}$, $R_L=10\text{ohm}$ | | | | |
| C_{SS} | $V_{IN}=5.0\text{V}$ | $V_{IN}=8.4\text{V}$ | $V_{IN}=10\text{V}$ | $V_{IN}=12\text{V}$ |
| 1nF | 20.9 | 17.3 | 16.5 | 16.0 |
| 10nF | 143 | 135 | 133 | 138 |
| 100nF | 1430 | 1392 | 1438 | 1502 |

Table 1 Timing Capacitors and Rise Times

Adjustable Discharge

When EN goes low, V_{OUT} is discharged to ground through the discharge resistor (R_{DIS}) on the DIS pin. A value greater than 243Ω is recommended for R_{DIS} .

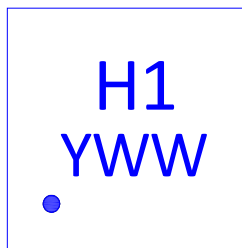
While the discharge/fall-time on V_{OUT} can be controlled using R_{DIS} , capacitors on V_{OUT} and SS also contribute to the timing. Higher discharge resistance increases the RC time constant and hence, the discharge time. Fall times (μS) for different values of R_{DIS} and V_{IN} are shown in the table below with $V_{BIAS} = 5.5\text{V}$.

| 1206 250mW 1% Discharge resistorT | Fall Time (μS) | | | |
|--------------------------------------|--|----------------------|---------------------|---------------------|
| | Measured at +25°C, $C_L=100\text{nF}$, $R_L=Open$ | | | |
| | $V_{IN}=5.0\text{V}$ | $V_{IN}=8.4\text{V}$ | $V_{IN}=10\text{V}$ | $V_{IN}=12\text{V}$ |
| 243 Ω | 67.2 | 69.3 | 70.4 | 71.5 |
| 1,000 Ω | 285 | 291 | 296 | 301 |
| 3,900 Ω | 1020 | 1030 | 1050 | 1080 |

Table 2 Discharge Resistors and Output Voltage Fall Time

Ordering & Marking Information

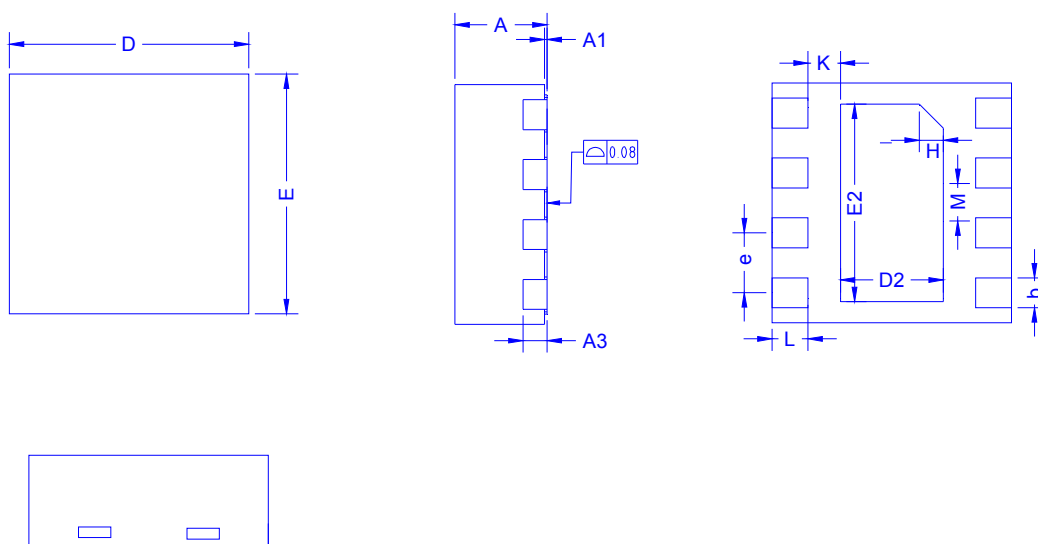
Device Name: EM5220VDT for TDFN2.0X2.0-08



H1: Device Code, H1 for EM5220VDT
 YWW: Date Code

Outline Drawing

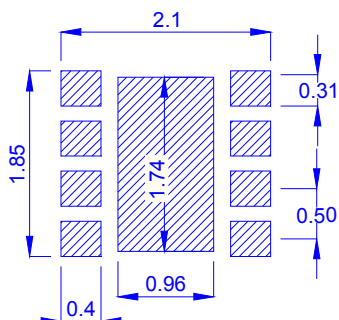
TDFN2.0X2.0-08



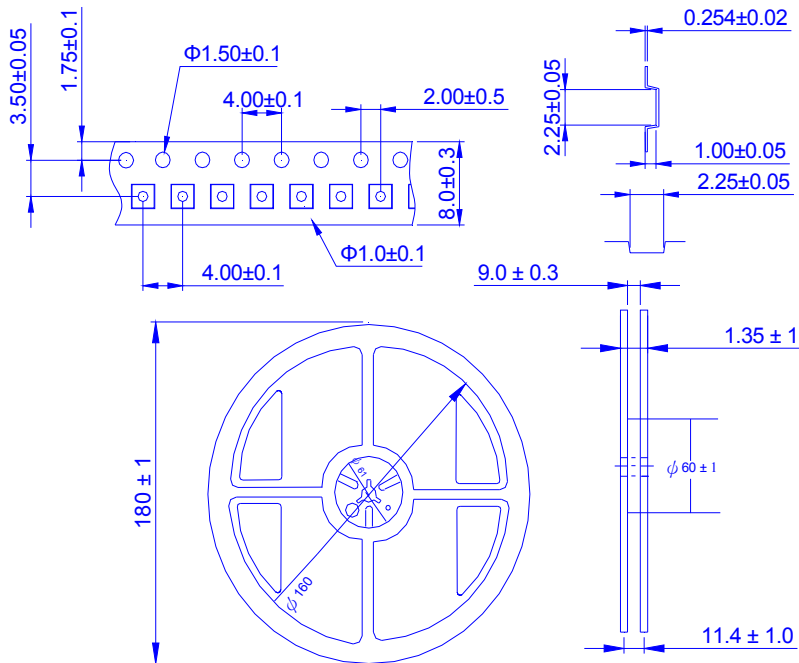
Dimension in mm

| Dimension | A | A1 | A3 | b | D | E | D2 | E2 | e | K | L | H |
|-----------|------|------|------|------|-----|-----|-----|-----|-----|------|------|---------|
| Min. | 0.50 | 0 | | 0.20 | 1.9 | 1.9 | 0.8 | 1.5 | 0.4 | 0.15 | 0.25 | |
| Typ. | 0.55 | | 0.15 | 0.25 | 2.0 | 2.0 | 0.9 | 1.6 | 0.5 | 0.25 | 0.30 | 0.2 FER |
| Max. | 0.65 | 0.05 | | 0.30 | 2.1 | 2.1 | 1.0 | 1.7 | 0.6 | 0.35 | 0.35 | |

Recommended minimum pads



Tape&Reel Information:3000pcs/Reel



| | |
|---------|-----------------------|
| 產品別 | TDFN2.0X2.0-08 |
| Reel 尺寸 | 7" |
| 編帶方式 | <p>FEED DIRECTION</p> |
| 前空格 | 50 |
| 後空格 | 50 |
| 裝箱數 | |
| 滿捲數量 | 3K |
| 捲/內盒比 | 5 : 1 |
| 內盒滿箱數 | 15K |
| 內/外箱比 | 12 : 1 |
| 外箱滿箱數 | 180K |